

Features

- Fast read access time – 70ns
- Dual voltage range operation
 - Low voltage power supply range, 3.0V to 3.6V, or
 - Standard power supply range, 5V \pm 10%
- Compatible with JEDEC standard Atmel® AT27C010
- Low-power CMOS operation
 - 20 μ A max standby (less than 1 μ A, typical) for V_{CC} = 3.6V
 - 29mW max active at 5MHz for V_{CC} = 3.6V
- JEDEC standard package
 - 32-lead PLCC
- High-reliability CMOS technology
 - 2,000V ESD protection
 - 200mA latchup immunity
- Rapid programming algorithm – 100 μ s/byte (typical)
- CMOS- and TTL-compatible inputs and outputs
 - JEDEC standard for LVTTTL
- Integrated product identification code
- Industrial temperature range
- Green (Pb/halide-free) packaging option

1. Description

The Atmel AT27LV010A is a high-performance, low-power, low-voltage 1,048,576-bit, one-time programmable, read-only memory (OTP EPROM) organized as 128K by 8 bits. It requires only one supply in the range of 3.0V to 3.6V in normal read mode operation, making it ideal for fast, portable systems using battery power.

The Atmel innovative design techniques provide fast speeds that rival 5V parts, while keeping the low power consumption of a 3.3V supply. At V_{CC} = 3.0V, any byte can be accessed in less than 70ns. With a typical power dissipation of only 18mW at 5MHz and V_{CC} = 3.3V, the AT27LV010A consumes less than one-fifth the power of a standard, 5V EPROM. Standby mode supply current is typically less than 1 μ A at 3.3V.

The AT27LV010A is available in an industry-standard, JEDEC-approved, one-time programmable (OTP) PLCC package. All devices feature two-line control (\overline{CE} , \overline{OE}) to give designers the flexibility to prevent bus contention.

The AT27LV010A operating with V_{CC} at 3.0V produces TTL-level outputs that are compatible with standard TTL logic devices operating at V_{CC} = 5.0V. The device is also capable of standard, 5V operation, making it ideally suited for dual supply range systems or card products that are pluggable in both 3V and 5V hosts.

The AT27LV010A has additional features to ensure high quality and efficient production use. The rapid programming algorithm reduces the time required to program the part and guarantees reliable programming. Programming time is typically only 100 μ s/byte. The integrated product identification code electronically identifies the device and manufacturer. This feature is used by industry-standard programming equipment to select the proper programming algorithms and voltages. The AT27LV010A programs in exactly the same way as a standard, 5V Atmel AT27C010, and uses the same programming equipment.



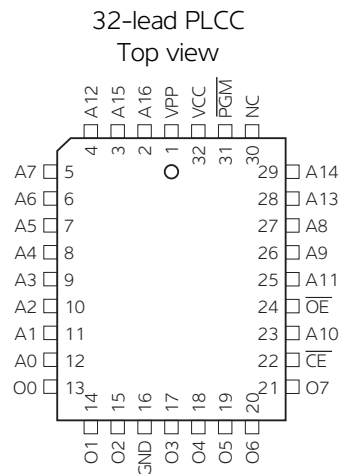
1Mb (128K x 8)
Low Voltage,
One-time
Programmable,
Read-only Memory

Atmel AT27LV010A



2. Pin configurations

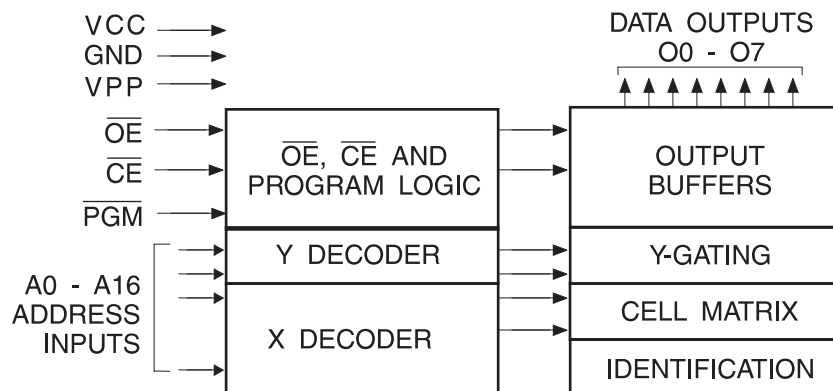
| Pin name | Function |
|------------------|----------------|
| A0 - A16 | Addresses |
| O0 - O7 | Outputs |
| \overline{CE} | Chip enable |
| \overline{OE} | Output enable |
| \overline{PGM} | Program strobe |
| NC | No connect |



3. System considerations

Switching between active and standby conditions via the chip enable pin may produce transient voltage excursions. Unless accommodated by the system design, these transients may exceed datasheet limits, resulting in device nonconformance. At a minimum, a 0.1 μ F, high-frequency, low inherent inductance, ceramic capacitor should be utilized for each device. This capacitor should be connected between the V_{CC} and ground terminals of the device, as close to the device as possible. Additionally, to stabilize the supply voltage level on printed circuit boards with large EPROM arrays, a 4.7 μ F bulk electrolytic capacitor should be utilized, again connected between the V_{CC} and ground terminals. This capacitor should be positioned as close as possible to the point where the power supply is connected to the array.

Figure 3-1. Block diagram



4. Absolute maximum ratings*

| | |
|--|--------------------------------|
| Temperature under bias | -40°C to +85°C |
| Storage temperature | -65°C to +125°C |
| Voltage on any pin with respect to ground | -2.0V to +7.0V ⁽¹⁾ |
| Voltage on A9 with respect to ground | -2.0V to +14.0V ⁽¹⁾ |
| V _{pp} supply voltage with respect to ground | -2.0V to +14.0V ⁽¹⁾ |

*NOTICE: Stresses beyond those listed under “Absolute maximum ratings” may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Note: 1. Minimum voltage is -0.6V DC, which may undershoot to -2.0V for pulses of less than 20ns. Maximum output pin voltage is V_{CC} + 0.75V DC, which may be exceeded if certain precautions are observed (consult application notes), and which may overshoot to +7.0V for pulses of less than 20ns.

5. DC and AC characteristics

Table 5-1. Operating modes

| Mode/Pin | \overline{CE} | \overline{OE} | \overline{PGM} | Ai | V _{PP} | V _{CC} | Outputs |
|--|-----------------|-----------------|------------------|---|-----------------|-----------------|---------------------|
| Read ⁽²⁾ | V _{IL} | V _{IL} | X ⁽¹⁾ | Ai | X | V _{CC} | D _{OUT} |
| Output disable ⁽²⁾ | X | V _{IH} | X | X | X | V _{CC} | High Z |
| Standby ⁽²⁾ | V _{IH} | X | X | X | X | V _{CC} | High Z |
| Rapid program ⁽³⁾ | V _{IL} | V _{IH} | V _{IL} | Ai | V _{PP} | V _{CC} | D _{IN} |
| PGM verify ⁽³⁾ | V _{IL} | V _{IL} | V _{IH} | Ai | V _{PP} | V _{CC} | D _{OUT} |
| PGM inhibit ⁽³⁾ | V _{IH} | X | X | X | V _{PP} | V _{CC} | High Z |
| Product identification ⁽³⁾⁽⁵⁾ | V _{IL} | V _{IL} | X | A9 = V _H ⁽⁴⁾ A0 = V _{IH} or V _{IL} A1 - A16 = V _{IL} | X | V _{CC} | Identification code |

Note: 1. X can be V_{IL} or V_{IH}.
 2. Read, output disable, and standby modes require $3.0V \leq V_{CC} \leq 3.6V$ or $4.5V \leq V_{CC} \leq 5.5V$.
 3. Refer to programming characteristics. Programming modes require V_{CC} = 6.5V.
 4. V_H = 12.0 ± 0.5V.
 5. Two identifier bytes may be selected. All Ai inputs are held low (V_{IL}), except A9, which is set to V_H, and A0, which is toggled low (V_{IL}) to select the manufacturer's identification byte and high (V_{IH}) to select the device code byte.

Table 5-2. DC and AC operating conditions for read operation

| | Atmel AT27LV010A-70 |
|---|---------------------|
| Industrial operating temperature (case) | -40°C - 85°C |
| V _{CC} power supply | 3.0V to 3.6V |
| | 5V ± 10% |

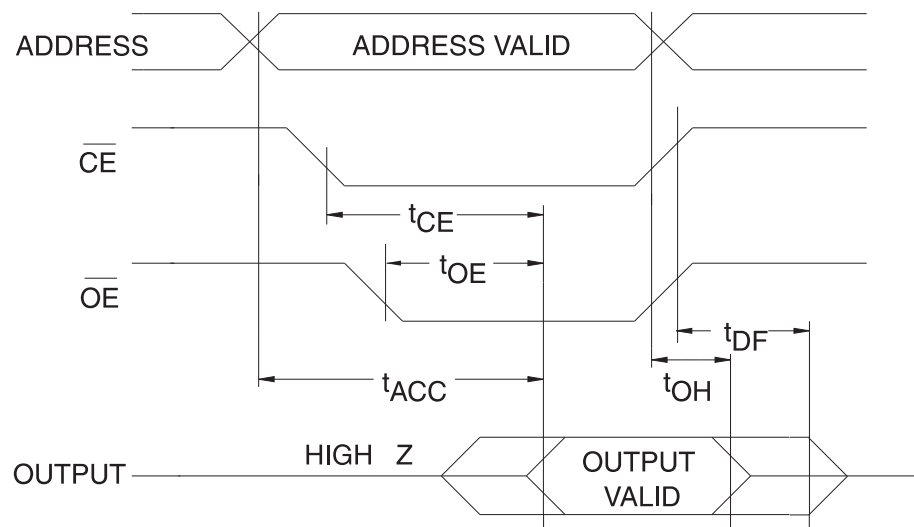
Table 5-3. DC and operating characteristics for read operation

| Symbol | Parameter | Condition | Min | Max | Units |
|--|-------------------------------------|---|------|----------------|---------|
| $V_{CC} = 3.0V$ to $3.6V$ | | | | | |
| I_{LI} | Input load current | $V_{IN} = 0V$ to V_{CC} | | ± 1 | μA |
| I_{LO} | Output leakage current | $V_{OUT} = 0V$ to V_{CC} | | ± 5 | μA |
| $I_{PP1}^{(2)}$ | $V_{PP}^{(1)}$ read/standby current | $V_{PP} = V_{CC}$ | | 10 | μA |
| I_{SB} | $V_{CC}^{(1)}$ standby current | I_{SB1} (CMOS), $\overline{CE} = V_{CC} \pm 0.3V$ | | 20 | μA |
| | | I_{SB2} (TTL), $\overline{CE} = 2.0$ to $V_{CC} + 0.5V$ | | 100 | μA |
| I_{CC} | V_{CC} active current | $f = 5MHz$, $I_{OUT} = 0mA$, $\overline{CE} = V_{IL}$ | | 8 | mA |
| V_{IL} | Input low voltage | | -0.6 | 0.8 | V |
| V_{IH} | Input high voltage | | 2.0 | $V_{CC} + 0.5$ | V |
| V_{OL} | Output low voltage | $I_{OL} = 2.0mA$ | | 0.4 | V |
| V_{OH} | Output high voltage | $I_{OH} = -2.0mA$ | 2.4 | | V |
| $V_{CC} = 4.5V$ to $5.5V$ | | | | | |
| I_{LI} | Input load current | $V_{IN} = 0V$ to V_{CC} | | ± 1 | μA |
| I_{LO} | Output leakage current | $V_{OUT} = 0V$ to V_{CC} | | ± 5 | μA |
| $I_{PP1}^{(2)}$ | $V_{PP}^{(1)}$ read/standby current | $V_{PP} = V_{CC}$ | | 10 | μA |
| I_{SB} | $V_{CC}^{(1)}$ standby current | I_{SB1} (CMOS), $\overline{CE} = V_{CC} \pm 0.3V$ | | 100 | μA |
| | | I_{SB2} (TTL), $\overline{CE} = 2.0$ to $V_{CC} + 0.5V$ | | 1 | mA |
| I_{CC} | V_{CC} active current | $f = 5MHz$, $I_{OUT} = 0mA$, $\overline{CE} = V_{IL}$ | | 25 | mA |
| V_{IL} | Input low voltage | | -0.6 | 0.8 | V |
| V_{IH} | Input high voltage | | 2.0 | $V_{CC} + 0.5$ | V |
| V_{OL} | Output low voltage | $I_{OL} = 2.1mA$ | | 0.4 | V |
| V_{OH} | Output high voltage | $I_{OH} = -400\mu A$ | 2.4 | | V |

- Notes: 1. V_{CC} must be applied simultaneously with or before V_{PP} , and removed simultaneously with or after V_{PP} .
2. V_{PP} may be connected directly to V_{CC} , except during programming. The supply current would then be the sum of I_{CC} and I_{PP} .

Table 5-4. AC characteristics for read operation

| Symbol | Parameter | Condition | Atmel AT27LV010A-70 | | Units |
|-------------------|---|--|---------------------|-----|-------|
| | | | Min | Max | |
| $t_{ACC}^{(3)}$ | Address to output delay | $\overline{CE} = \overline{OE} = V_{IL}$ | | 70 | ns |
| $t_{CE}^{(2)}$ | \overline{CE} to output delay | $\overline{OE} = V_{IL}$ | | 70 | ns |
| $t_{OE}^{(2)(3)}$ | \overline{OE} to output delay | $\overline{CE} = V_{IL}$ | | 40 | ns |
| $t_{DF}^{(4)(5)}$ | \overline{OE} or \overline{CE} high to output float, whichever occurred first | | | 35 | ns |
| t_{OH} | Output hold from address, \overline{CE} or \overline{OE} , whichever occurred first | | 0 | | ns |

Figure 5-1. AC waveforms for read operation⁽¹⁾

- Notes:
1. Timing measurement references are 0.8V and 2.0V. Input AC drive levels are 0.45V and 2.4V, unless otherwise specified.
 2. \overline{OE} may be delayed up to $t_{CE} - t_{OE}$ after the falling edge of \overline{CE} without impact on t_{CE} .
 3. \overline{OE} may be delayed up to $t_{ACC} - t_{OE}$ after the address is valid without impact on t_{ACC} .
 4. This parameter is only sampled, and is not 100% tested.
 5. Output float is defined as the point when data is no longer driven.

Figure 5-2. Input test waveforms and measurement level

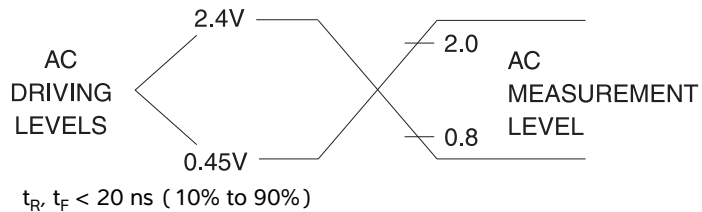
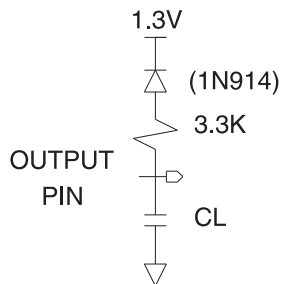


Figure 5-3. Output test load



Note: CL = 100pF including jig capacitance.

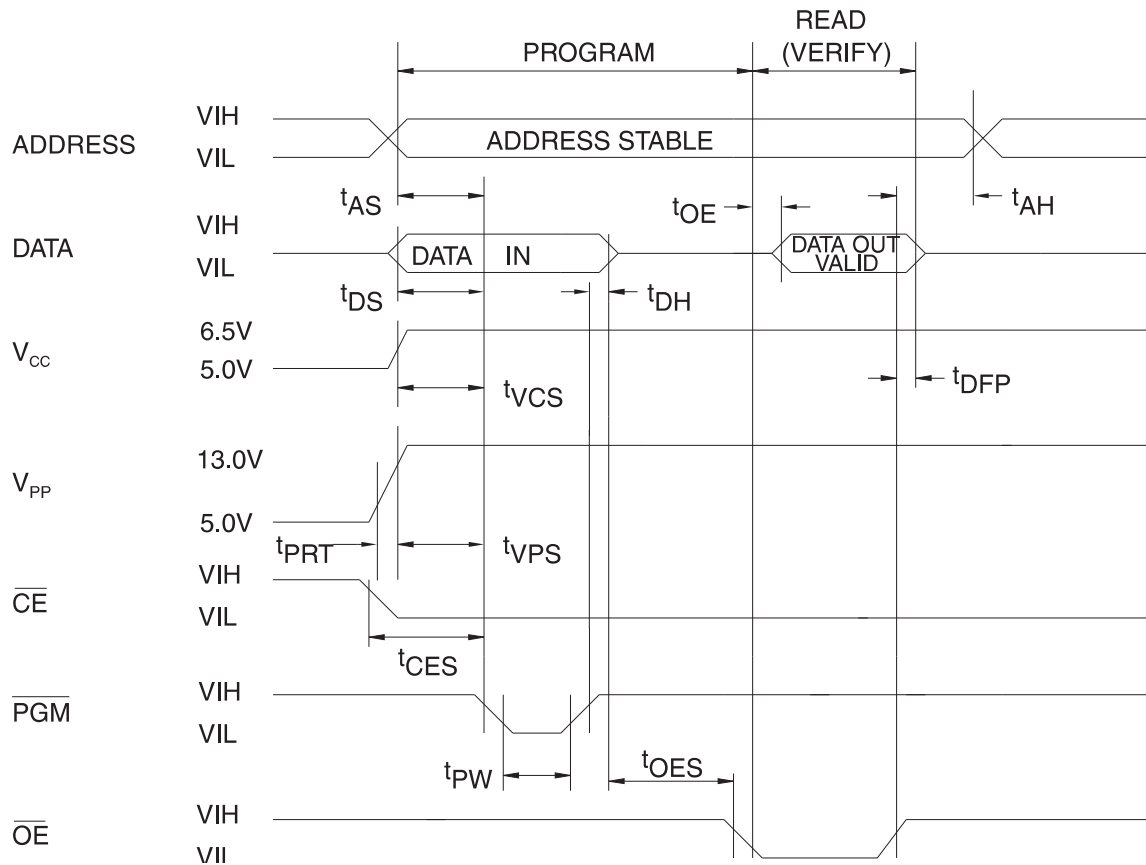
Table 5-5. Pin capacitance

$f = 1\text{MHz}$, $T = 25^\circ\text{C}$ ⁽¹⁾

| Symbol | Typ | Max | Units | Conditions |
|------------------|-----|-----|-------|------------------------------|
| C_{IN} | 4 | 8 | pF | $V_{\text{IN}} = 0\text{V}$ |
| C_{OUT} | 8 | 12 | pF | $V_{\text{OUT}} = 0\text{V}$ |

Note: 1. Typical values for nominal supply voltage. This parameter is only sampled, and is not 100% tested.

Figure 5-4. Programming waveforms⁽¹⁾



- Notes:
1. The input timing reference is 0.8V for V_{IL} and 2.0V for V_{IH} .
 2. t_{OE} and t_{DFP} are characteristics of the device, but must be accommodated by the programmer.
 3. When programming the Atmel AT27LV010A, a 0.1 μF capacitor is required across V_{PP} and ground to suppress spurious voltage transients.

Table 5-6. DC programming characteristics

 $T_A = 25 \pm 5^\circ\text{C}$, $V_{CC} = 6.5 \pm 0.25\text{V}$, $V_{PP} = 13.0 \pm 0.25\text{V}$

| Symbol | Parameter | Test conditions | Limits | | Units |
|-----------|--|---|--------|----------------|---------------|
| | | | Min | Max | |
| I_{LI} | Input load current | $V_{IN} = V_{IL}, V_{IH}$ | | ± 10 | μA |
| V_{IL} | Input low level | | -0.6 | 0.8 | V |
| V_{IH} | Input high level | | 2.0 | $V_{CC} + 0.5$ | V |
| V_{OL} | Output low voltage | $I_{OL} = 2.1\text{mA}$ | | 0.4 | V |
| V_{OH} | Output high voltage | $I_{OH} = -400\mu\text{A}$ | 2.4 | | V |
| I_{CC2} | V_{CC} supply current (program and verify) | | | 40 | mA |
| I_{PP2} | V_{PP} supply current | $\overline{CE} = \overline{PGM} = V_{IL}$ | | 20 | mA |
| V_{ID} | A9 product identification voltage | | 11.5 | 12.5 | V |

Table 5-7. AC programming characteristics

 $T_A = 25 \pm 5^\circ\text{C}$, $V_{CC} = 6.5 \pm 0.25\text{V}$, $V_{PP} = 13.0 \pm 0.2\text{V}$

| Symbol | Parameter | Test conditions ⁽¹⁾ | Limits | | Units |
|-----------|---|--|--------|-----|---------------|
| | | | Min | Max | |
| t_{AS} | Address setup time | Input rise and fall times (10% to 90%) 20ns | 2 | | μs |
| t_{CES} | \overline{CE} setup time | | 2 | | μs |
| t_{OES} | \overline{OE} setup time | | 2 | | μs |
| t_{DS} | Data setup time | | 2 | | μs |
| t_{AH} | Address hold time | Input pulse levels 0.45V to 2.4V | 0 | | μs |
| t_{DH} | Data hold time | | 2 | | μs |
| t_{DFP} | \overline{OE} high to output float delay ⁽²⁾ | Input timing reference level 0.8V to 2.0V | 0 | 130 | ns |
| t_{VPS} | V_{PP} setup time | | 2 | | μs |
| t_{VCS} | V_{CC} setup time | Output timing reference level 0.8V to 2.0V | 2 | | μs |
| t_{PW} | \overline{PGM} program pulse width ⁽³⁾ | | 95 | 105 | μs |
| t_{OE} | Data valid from \overline{OE} | | | 150 | ns |
| t_{PRT} | V_{PP} pulse rise time during programming | | 50 | | ns |

- Notes:
1. V_{CC} must be applied simultaneously with or before V_{PP} and removed simultaneously with or after V_{PP} .
 2. This parameter is only sampled, and is not 100% tested. Output float is defined as the point where data is no longer driven. See timing diagram.
 3. Program pulse width tolerance is $100 \mu\text{sec} \pm 5\%$.

Table 5-8. The Atmel AT27LV010A integrated product identification code⁽¹⁾

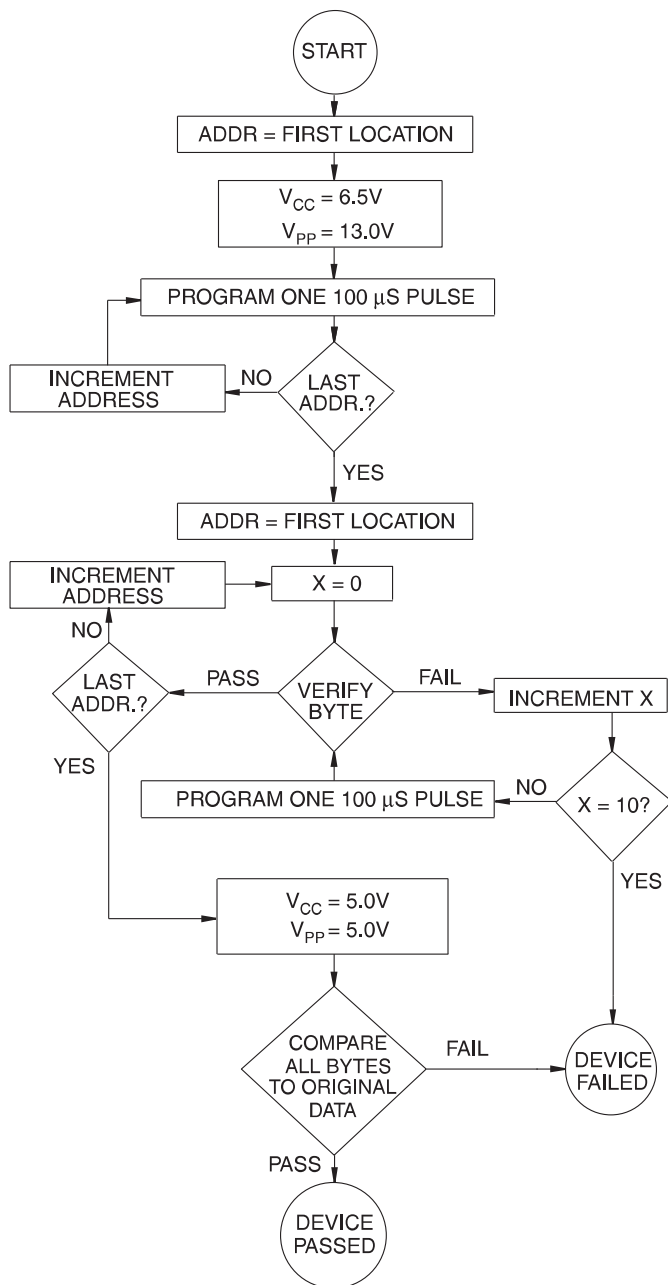
| Codes | Pins | | | | | | | | | Hex data |
|--------------|------|----|----|----|----|----|----|----|----|----------|
| | A0 | O7 | O6 | O5 | O4 | O3 | O2 | O1 | O0 | |
| Manufacturer | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 | 0 | 1E |
| Device type | 1 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | 05 |

- Note:
1. The Atmel AT27LV010A has the same product identification code as the Atmel AT27C010. Both are programming compatible.

6. Rapid programming algorithm

A $100\mu\text{s}$ $\overline{\text{PGM}}$ pulse width is used to program. The address is set to the first location. V_{CC} is raised to 6.5V and V_{PP} is raised to 13.0V. Each address is first programmed with one $100\mu\text{s}$ $\overline{\text{PGM}}$ pulse without verification. Then a verification/reprogramming loop is executed for each address. In the event a byte fails to pass verification, up to 10 successive $100\mu\text{s}$ pulses are applied with a verification after each pulse. If the byte fails to verify after 10 pulses have been applied, the part is considered failed. After the byte verifies properly, the next address is selected until all have been checked. V_{PP} is then lowered to 5.0V and V_{CC} to 5.0V. All bytes are read again and compared with the original data to determine if the device passes or fails.

Figure 6-1. Rapid programming algorithm



7. Ordering information

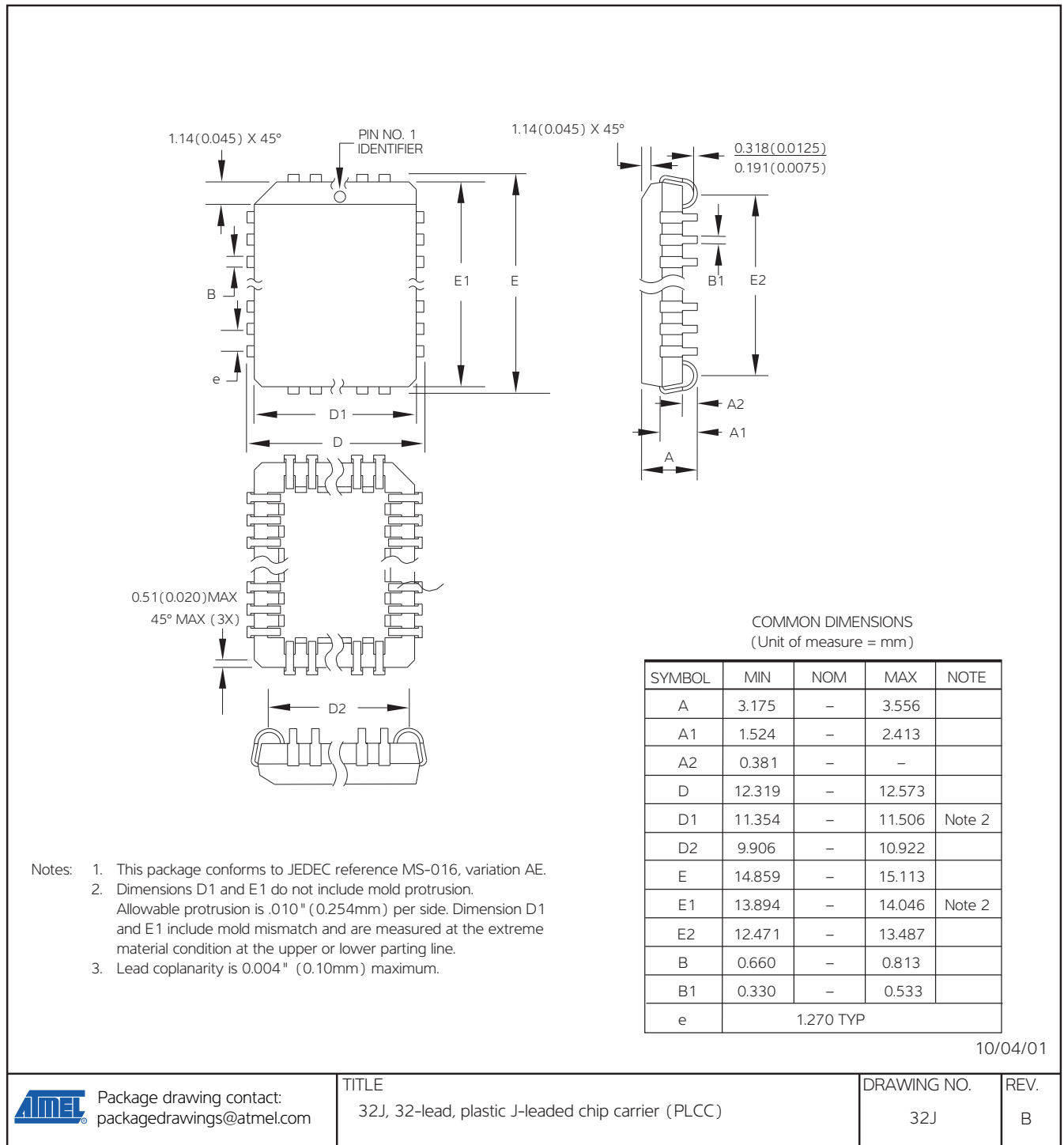
Green package option (Pb/halide-free)

| t_{ACC} (ns) | I_{CC} (mA) $V_{CC} = 3.6V$ | | Atmel ordering code | Package | Lead finish | Operation range |
|-------------------|----------------------------------|---------|---------------------|---------|-------------|-------------------------------|
| | Active | Standby | | | | |
| 70 | 8 | 0.02 | AT27LV010A-70JU | 32J | Matte tin | Industrial (-40°C to 85°C) |

| Package type | |
|--------------|--|
| 32J | 32-lead, plastic, J-leaded chip carrier (PLCC) |

8. Packaging Information

32J – PLCC



9. Revision history

| Doc. rev. | Date | Comments |
|-----------|---------|--|
| 0548F | 04/2011 | Remove TSOP and VSOP packages Add lead finish to ordering information |
| 0548E | 12/2007 | |

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